Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/718,242	CHIN ET AL.	
Examiner	Art Unit	
Temica M Beamer	2681	

SEARCHED				
Class	Subclass	Date	Examiner	
455	414.1	7/23/2005	ТМВ	
455	405	7/23/2005	TMB	
455	406	7/23/2005	ТМВ	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
WEST text search	7/23/2005	ТМВ	